

Search Notes**Application/Control No.**

10/705,863

Examiner

Duc M. Nguyen

Applicant(s)/Patent under Reexamination

HIBINO ET AL.

Art Unit

2685

SEARCHED

Class	Subclass	Date	Examiner
455	193.1 193.2 193.3		
	199.1		
	179.1		
	180.2		
	188.1		
	188.2		
	191.2		
	191.3		
	269 275		
	285->291		
	339 340		
333	124 129		
	132 32 172		
	174 227 231	3/6/06	BN✓

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	2/21/2006	DN
EAST	3/6/2006	DN